


<b>Search Notes</b> 	<b>Application/Control No.</b> 10563892	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> BRIAN P YENKE	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	557, 558, 465, 467	29 Aug 08	BPY
	569, 563, 564, 565		
	575, 581, 582, 584, 441		
		26 Feb 10	BPY

SEARCH NOTES		
Search Notes	Date	Examiner
Update Search	26 Feb 10	BPY

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See Above		26 Feb 10	BPY

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